ES036D - JULY 1995 - REVISED MARCH 2000

	SCES036D	– JULY 1995 – REV
 Member of the Texas Instruments Widebus[™] Family 		ACKAGE VIEW)
 EPIC[™] (Enhanced-Performance Implanted CMOS) Submicron Process 	V _{CC} 1 GND 2	80 V _{CC} 79 GND
 ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0) 	2B9 3 1B9 4 2B8 5	78 1B10 77 2B10 76 1B11
 Latch-up Performance Exceeds 250 mA Per JESD 17 	GND 6 1B8 7	75 GND 74 2B11
 Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors 	2B7 []8 1B7 []9 V _{CC} []10	73] 1B12 72] 2B12 71] V _{CC}
 Packaged in Thin Very Small-Outline Package 	2B6 [11 1B6 [12	70 1B13 69 2B13
NOTE: For tape and reel order entry: The DBBR package is abbreviated to GR.	2B5 13 1B5 14 GND 15	68 31B14 67 2B14 66 GND
description	2B4 🚺 16 1B4 🚺 17	65] 1B15 64] 2B15
The SN74ALVCH16282 is an 18-bit to 36-bit registered bus exchanger designed for 1.65-V to 3.6-V V_{CC} operation.	2B3	63] 1B16 62] 2B16 61] V _{CC}
This device is intended for use in applications in which data must be transferred from a narrow high-speed bus to a wide lower-frequency bus. It is designed specifically for low-voltage (3.3-V) V_{CC} operation.	GND [21 2B2 [22 1B2 [23 2B1 [24 1B1 [25	60 GND 59 1B17 58 2B17 57 1B18 56 2B18
The device provides synchronous data exchange between the two ports. Data is stored in the internal registers on the low-to-high transition of the clock (CLK) input. For data transfer in the B-to-A direction, the select (SEL) input selects 1B or 2B data for the A outputs.	V _{CC} [26 A1 [27 A2 [28 A3 [29 GND [30 A4 [31	55] V _{CC} 54] A18 53] A17 52] A16 51] GND 50] A15
For data transfer in the A-to-B direction, a two-stage pipeline is provided in the 1B path, with a single storage register in the 2B path. Data flow	A5 [] 32 A6 [] 33 V _{CC} [] 34 A7 [] 35	49 A14 48 A13 47 V _{CC} 46 A12

two-stage pipeline is provided in the 1B path, with a single storage register in the 2B path. Data flow is controlled by the active-low output enable (\overline{OE}) and the DIR input. The DIR control pin is registered to synchronize the bus direction changes with the clock.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH16282 is characterized for operation from -40° C to 85° C.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



45 🛛 A11

44 🛛 A10

43 GND

42 0E

41] DIR

A8 36

A9 🛛

GND

CLK L

SEL

37

38

39

40

SN74ALVCH16282 18-BIT TO 36-BIT REGISTERED BUS EXCHANGER WITH 3-STATE OUTPUTS SCES036D – JULY 1995 – REVISED MARCH 2000

Function Tables

A-TO-B	STORAGE	OE = L.	DIR = H)

		,	,	,
	INPUTS		OUTI	PUTS
SEL	CLK	Α	1B	2B
Н	Х	Х	1B0†	2B0†
L	\uparrow	L	L‡	х
L	Ŷ	Н	н‡	Х

[†]Output level before indicated steady-state input conditions were established

[‡] Two CLK edges are needed to propagate the data.

B-TO-A STORAGE ($\overline{OE} = L$, DIR = L)

	INPUTS								
CLK	SEL	1B	2B	Α					
\uparrow	Н	Х	L	L§					
↑ (Н	Х	н	Н§					
↑ (L	L	Х	L					
\uparrow	L	н	Х	н					

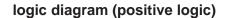
§ Two CLK edges are needed to propagate the data. The data is loaded in the first register when SEL is low and propagates to the second register when SEL is high.

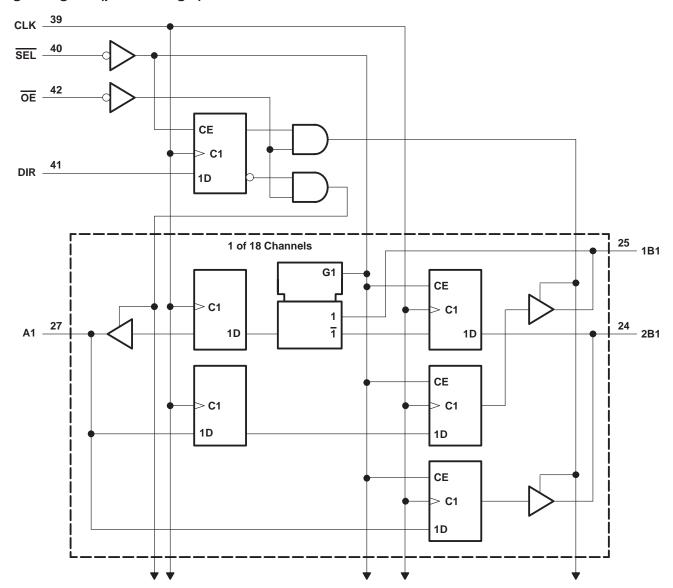
OUTPUT ENABLE

	INPUTS		OUT	PUTS
CLK	OE	DIR	Α	1B, 2B
\uparrow	Н	Х	Z	Z
\uparrow	L	н	z	Active
↑	L	L	Active	Z



SN74ALVCH16282 **18-BIT TO 36-BIT REGISTERED BUS EXCHANGER** WITH 3-STATE OUTPUTS SCES036D – JULY 1995 – REVISED MARCH 2000







SN74ALVCH16282 **18-BIT TO 36-BIT REGISTERED BUS EXCHANGER** WITH 3-STATE OUTPUTS SCES036D - JULY 1995 - REVISED MARCH 2000

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. This value is limited to 4.6 V maximum.

3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
VCC	Supply voltage		1.65	3.6	V
		V _{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		
VIH	High-level input voltage	V_{CC} = 2.3 V to 2.7 V	1.7		V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	2		
		V _{CC} = 1.65 V to 1.95 V		$0.35 \times V_{CC}$	
\vee_{IL}	Low-level input voltage	V_{CC} = 2.3 V to 2.7 V		0.7	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$		0.8	
VI	Input voltage		0	VCC	V
VO	Output voltage		0	VCC	V
		V _{CC} = 1.65 V		-4	
1		V _{CC} = 2.3 V		-12	A
ЮН	High-level output current	V _{CC} = 2.7 V		-12	mA
		V _{CC} = 3 V		-24	
		V _{CC} = 1.65 V		4	
		V _{CC} = 2.3 V		12	A
IOL	Low-level output current	V _{CC} = 2.7 V		12	mA
		V _{CC} = 3 V		24	
$\Delta t/\Delta v$	Input transition rise or fall rate	·		10	ns/V
TA	Operating free-air temperature		-40	85	°C

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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PARAMETER	TEST CONDITIONS	V _{CC}	MIN	ТҮРТ МА	X UNIT
	I _{OH} = -100 μA	1.65 V to 3.6 V	V _{CC} -0.2		
	I _{OH} = -4 mA	1.65 V	1.2		7
	I _{OH} = -6 mA	2.3 V	2		
VOH		2.3 V	1.7		V
	I _{OH} = -12 mA	2.7 V	2.2		
		3 V	2.4		
	I _{OH} = -24 mA	3 V	2		
	I _{OL} = 100 μA	1.65 V to 3.6 V		0	2
	I _{OL} = 4 mA	1.65 V		0.4	5
	I _{OL} = 6 mA	2.3 V		0.	4 V
VOL	1	2.3 V		0.	7 V
	$I_{OL} = 12 \text{ mA}$	2.7 V		0.	4
	I _{OL} = 24 mA	3 V		0.5	5
l	$V_I = V_{CC} \text{ or } GND$	3.6 V		±	5 μΑ
	VI = 0.58 V	1.65 V	25		
	VI = 1.07 V	1.65 V	-25		
	$V_{I} = 0.7 V$	2.3 V	45		
II(hold)	V _I = 1.7 V	2.3 V	-45		μΑ
	VI = 0.8 V	3 V	75		
	VI = 2 V	3 V	-75		
	VI = 0 to 3.6 V [‡]	3.6 V		±50	0
IOZ§	$V_{O} = V_{CC} \text{ or } GND$	3.6 V		±1	0 μΑ
Icc	$V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$	3.6 V		4	0 μΑ
ΔICC	One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND	3 V to 3.6 V		75	0 μΑ
C _i Control inputs	$V_{I} = V_{CC}$ or GND	3.3 V		4	pF
Cio A or B ports	$V_{O} = V_{CC} \text{ or } GND$	3.3 V		8.5	pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C. [‡] This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another. $\$ For I/O ports, the parameter I_{OZ} includes the input leakage current.



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timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

			V _{CC} =	1.8 V	V _{CC} = ± 0.2		V _{CC} =	2.7 V	V _{CC} = ± 0.3		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
fclock	Clock frequency			†		150		150		150	MHz
tw	Pulse duration, CLK high or I	ow	†		3.3		3.3		3.3		ns
		A data before CLK↑	†		2.4		2.3		2		
	Catur time	B data before CLK↑	†		2.2		2.2		1.8		ns
^t su	Setup time	DIR before CLK↑	†		2.2		2.1		1.7		
		SEL before CLK↑	+		2		2		1.8		
		A data after CLK1	+		0.5		0.5		0.7		
4 .	Hold time	B data after CLK↑	+		0.5		0.5		0.6		ns
^t h		DIR after CLK↑	†		0.5		0.5		0.5		
		SEL after CLK↑	†		0.7		0.7		0.8		

[†] This information was not available at the time of publication.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} =	1.8 V	V _{CC} = ± 0.2	2.5 V 2 V	V _{CC} =	2.7 V	V _{CC} = ± 0.3	3.3 V 3 V	UNIT
		(001-01)	MIN	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
f _{max}			†		150		150		150		MHz
.	CLK	A		†	1	6.1		5.5	1.4	5	ns
^t pd	CLK	В		†	1.2	6.3		5.7	1.6	5.3	115
+	OE	A		†	1.3	6.9		6.3	1.2	5.7	200
ten	OE	В		†	2.3	8.7		8.1	2.3	7.4	ns
+	t _{dis} DE			†	1.5	7		5.6	1.8	5.7	ns
^t dis	UE	В		†	2.1	7.9		6.4	2.3	6.4	115

[†] This information was not available at the time of publication.

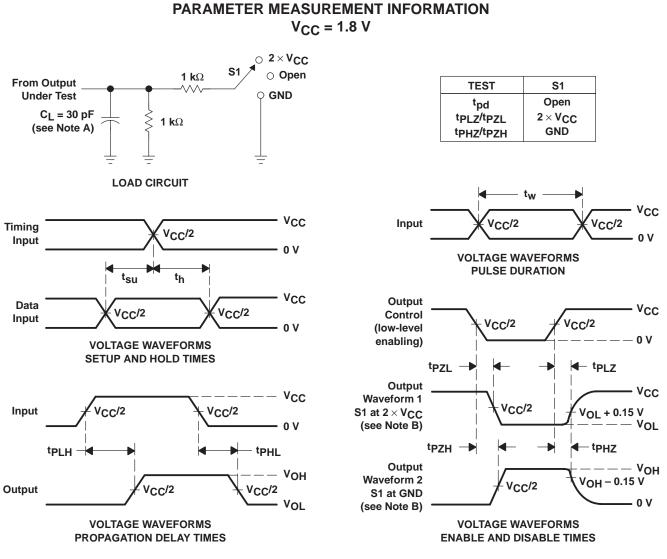
operating characteristics, T_A = 25°C

	PARAMETER		TEST CONDITIONS	V _{CC} = 1.8 V	V _{CC} = 2.5 V	V _{CC} = 3.3 V	UNIT
			TEST CONDITIONS	TYP	TYP	TYP	UNIT
	Power dissipation capacitance	Outputs enabled	C _I = 0. f = 10 MHz	†	282	310	рF
Cpd	Fower dissipation capacitance	Outputs disabled	$C_{L} = 0$, $f = 10 \text{ MHz}$	†	208	228	hL

[†] This information was not available at the time of publication.



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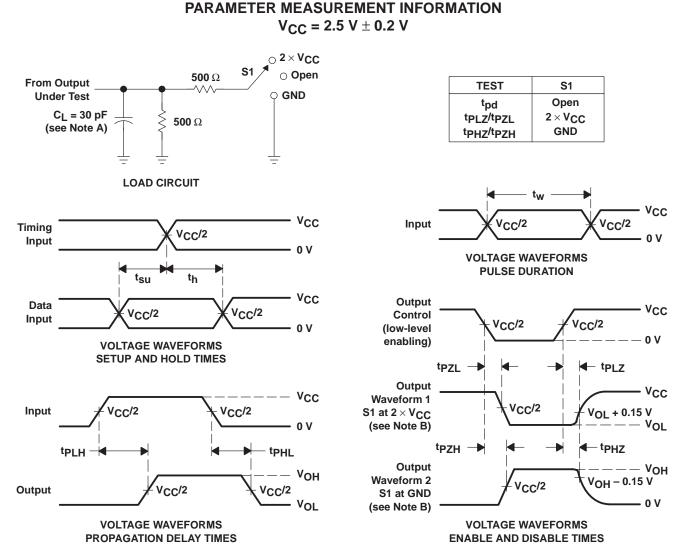


- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_f ≤ 2 ns, t_f ≤ 2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. tpzL and tpzH are the same as t_{en} .
 - G. tp_I H and tp_{HI} are the same as t_{pd} .
 - ·

Figure 1. Load Circuit and Voltage Waveforms



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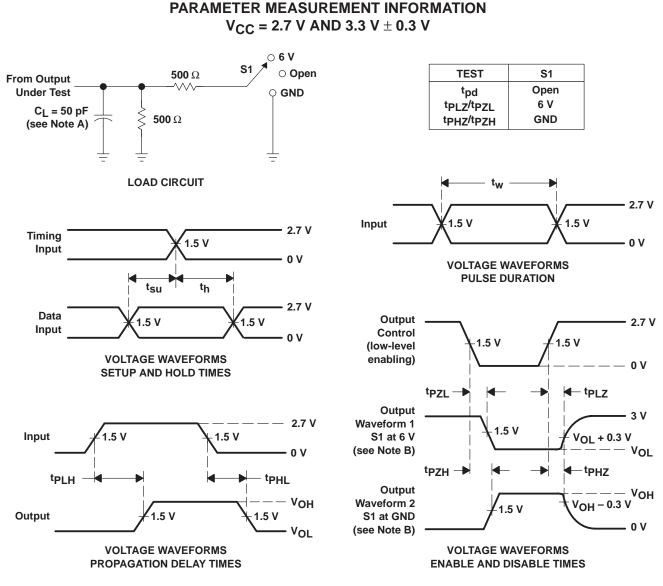


- NOTES: A. CI includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpl 7 and tpH7 are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



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- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PI7} and t_{PH7} are the same as t_{dis} .
 - F. t_{P7I} and t_{P7H} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 3. Load Circuit and Voltage Waveforms



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74ALVCH16282DBBRE4	ACTIVE	TSSOP	DBB	80	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16282DBBRG4	ACTIVE	TSSOP	DBB	80	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16282DBBR	ACTIVE	TSSOP	DBB	80	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



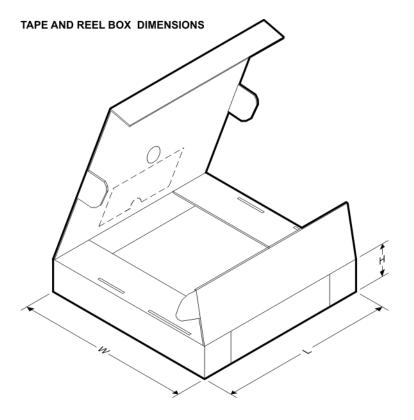
*All dimensions are nominal	

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVCH16282DBBR	TSSOP	DBB	80	2000	330.0	24.4	8.4	17.3	1.7	12.0	24.0	Q1



PACKAGE MATERIALS INFORMATION

11-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALVCH16282DBBR	TSSOP	DBB	80	2000	346.0	346.0	41.0

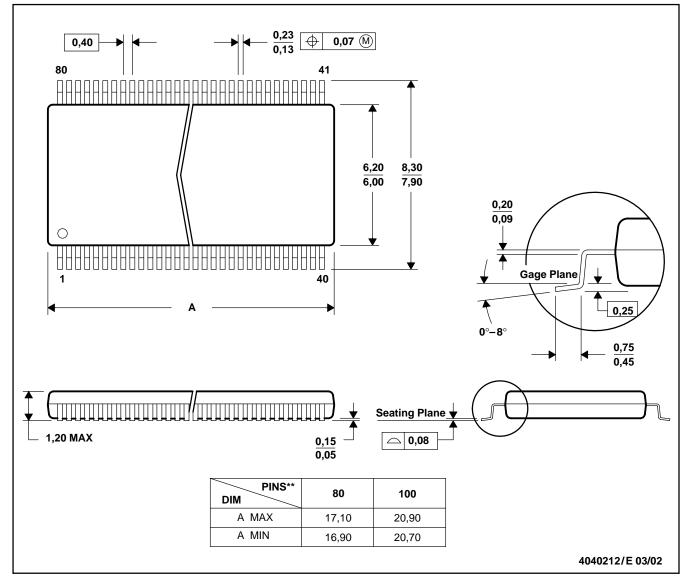
MECHANICAL DATA

MTSS005D - JANUARY 1995 - REVISED MARCH 2002

DBB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

80 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Falls within JEDEC : 80 Pin - MO-153 Variation FF

100 Pin – MO-194 Variation BB



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